

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567000	LEE ET AL.
	Examiner	Art Unit
	Jeffrey Lenihan	1796

SEARCHED

Class	Subclass	Date	Examiner
525	63, 64, 69, 100, 191, 209, 210, 474	10/6/2008	/JL/
525	63, 64, 69, 100, 191, 209, 210, 471	4/21/2009	/JL/
525	63, 64, 69, 100, 191, 209, 210, 471,902	10/21/2010	/JL/

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search in eDAN/PALM	10/6/2008	/JL/
See Attached EAST History	10/6/2008	/JL/
Online Search	10/6/2008	/JL/
updated EAST search	4/21/2009	/JL/
updated EAST history	11/3/2009	/JL/
updated EAST history	6/3/2010	/JL/
updated EAST history	10/21/2010	/JL/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--